

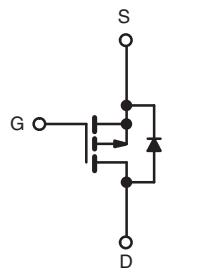
## FQD3P50TM-VB Datasheet

## P-Channel 500V (D-S) Power MOSFET

PRODUCT SUMMARY		
V <sub>DS</sub> (V)	- 500	
R <sub>DS(on)</sub> ( $\Omega$ )	V <sub>GS</sub> = - 10 V	2.0
Q <sub>g</sub> (Max.) (nC)	13	
Q <sub>gs</sub> (nC)	3.2	
Q <sub>gd</sub> (nC)	5.0	
Configuration	Single	

## FEATURES

- P-Channel
- Surface Mount
- Straight Lead
- Advanced Process Technology
- Fast Switching
- Fully Avalanche Rated



P-Channel MOSFET

ABSOLUTE MAXIMUM RATINGS (T <sub>C</sub> = 25 °C, unless otherwise noted)					
PARAMETER		SYMBOL	LIMIT	UNIT	
Drain-Source Voltage		V <sub>DS</sub>	- 500	V	
Gate-Source Voltage		V <sub>GS</sub>	± 20		
Continuous Drain Current	V <sub>GS</sub> at - 10 V	T <sub>C</sub> = 25 °C	- 4.0	A	
		T <sub>C</sub> = 100 °C	- 3.1		
Pulsed Drain Current <sup>a</sup>		I <sub>DM</sub>	-15		
Linear Derating Factor			0.40	W/°C	
Single Pulse Avalanche Energy <sup>b</sup>		E <sub>AS</sub>	92	mJ	
Repetitive Avalanche Current <sup>a</sup>		I <sub>AR</sub>	- 4	A	
Repetitive Avalanche Energy <sup>a</sup>		E <sub>AR</sub>	15.0	mJ	
Maximum Power Dissipation	T <sub>C</sub> = 25 °C	P <sub>D</sub>	80	W	
Peak Diode Recovery dV/dt <sup>c</sup>		dV/dt	- 24	V/ns	
Operating Junction and Storage Temperature Range		T <sub>J</sub> , T <sub>stg</sub>	- 55 to + 150	°C	
Soldering Recommendations (Peak Temperature) <sup>d</sup>	for 10 s		300		

## Notes

- Repetitive rating; pulse width limited by maximum junction temperature (see fig. 11).
- Starting T<sub>J</sub> = 25 °C, L = 57 mH, R<sub>g</sub> = 25 Ω, I<sub>AS</sub> = - 1.8 A (see fig. 12).
- I<sub>SD</sub> ≤ - 1.1 A, dI/dt ≤ 450 A/μs, V<sub>DD</sub> ≤ V<sub>DS</sub>, T<sub>J</sub> ≤ 150 °C.
- 1.6 mm from case.

<b>THERMAL RESISTANCE RATINGS</b>					
PARAMETER	SYMBOL	MIN.	TYP.	MAX.	UNIT
Maximum Junction-to-Ambient	$R_{thJA}$	-	-	110	°C/W
Maximum Junction-to-Ambient (PCB Mount) <sup>a</sup>	$R_{thJA}$	-	-	50	
Maximum Junction-to-Case (Drain)	$R_{thJC}$	-	-	2.5	

**Note**

- a. When mounted on 1" square PCB (FR-4 or G-10 material).

<b>SPECIFICATIONS</b> ( $T_J = 25^\circ\text{C}$ , unless otherwise noted)							
PARAMETER	SYMBOL	TEST CONDITIONS		MIN.	TYP.	MAX.	UNIT
<b>Static</b>							
Drain-Source Breakdown Voltage	$V_{DS}$	$V_{GS} = 0 \text{ V}$ , $I_D = -250 \mu\text{A}$		- 500	-	-	V
$V_{DS}$ Temperature Coefficient	$\Delta V_{DS}/T_J$	Reference to $25^\circ\text{C}$ , $I_D = -1 \text{ mA}$		-	- 0.41	-	$\text{V}/^\circ\text{C}$
Gate-Source Threshold Voltage	$V_{GS(th)}$	$V_{DS} = V_{GS}$ , $I_D = -250 \mu\text{A}$		- 2.0	-	- 4.0	V
Gate-Source Leakage	$I_{GSS}$	$V_{GS} = \pm 20 \text{ V}$		-	-	$\pm 100$	nA
Zero Gate Voltage Drain Current	$I_{DSS}$	$V_{DS} = -500 \text{ V}$ , $V_{GS} = 0 \text{ V}$		-	-	- 100	$\mu\text{A}$
		$V_{DS} = -400 \text{ V}$ , $V_{GS} = 0 \text{ V}$ , $T_J = 125^\circ\text{C}$		-	-	- 500	
Drain-Source On-State Resistance	$R_{DS(on)}$	$V_{GS} = -10 \text{ V}$	$I_D = -3.1 \text{ A}^b$	-	2	-	$\Omega$
Forward Transconductance	$G_{fs}$	$V_{DS} = -50 \text{ V}$ , $I_D = -3.1 \text{ A}$		0.91	-	-	S
<b>Dynamic</b>							
Input Capacitance	$C_{iss}$	$V_{GS} = 0 \text{ V}$ , $V_{DS} = -25 \text{ V}$ , $f = 1.0 \text{ MHz}$ , see fig. 5		-	270	-	pF
Output Capacitance	$C_{oss}$			-	50	-	
Reverse Transfer Capacitance	$C_{rss}$			-	8.0	-	
Total Gate Charge	$Q_g$	$V_{GS} = -10 \text{ V}$	$I_D = -1.1 \text{ A}$ , $V_{DS} = -320 \text{ V}$ , see fig. 6 and 13 <sup>b</sup>	-	-	13	nC
Gate-Source Charge	$Q_{gs}$			-	-	3.2	
Gate-Drain Charge	$Q_{gd}$			-	-	5.0	
Turn-On Delay Time	$t_{d(on)}$			-	11	-	
Rise Time	$t_r$	$V_{DD} = -200 \text{ V}$ , $I_D = -1.1 \text{ A}$ , $R_g = 21 \Omega$ , $R_D = 180 \Omega$ , see fig. 10 <sup>b</sup>		-	10	-	ns
Turn-Off Delay Time	$t_{d(off)}$		-	25	-		
Fall Time	$t_f$		-	24	-		
Internal Drain Inductance	$L_D$		-	4.5	-	nH	
Internal Source Inductance	$L_S$	Between lead, 6 mm (0.25") from package and center of die contact <sup>c</sup>		-	7.5		-
<b>Drain-Source Body Diode Characteristics</b>							
Continuous Source-Drain Diode Current	$I_S$	MOSFET symbol showing the integral reverse p-n junction diode		-	-	- 1.9	A
Pulsed Diode Forward Current <sup>a</sup>	$I_{SM}$			-	-	- 7.6	
Body Diode Voltage	$V_{SD}$	$T_J = 25^\circ\text{C}$ , $I_S = -1.1 \text{ A}$ , $V_{GS} = 0 \text{ V}^b$		-	-	- 4.0	V
Body Diode Reverse Recovery Time	$t_{rr}$	$T_J = 25^\circ\text{C}$ , $I_F = -1.1 \text{ A}$ , $dI/dt = 100 \text{ A}/\mu\text{s}^b$		-	170	260	ns
Body Diode Reverse Recovery Charge	$Q_{rr}$			-	640	960	nC
Forward Turn-On Time	$t_{on}$	Intrinsic turn-on time is negligible (turn-on is dominated by $L_S$ and $L_D$ )					

**Notes**

- a. Repetitive rating; pulse width limited by maximum junction temperature (see fig. 11).  
b. Pulse width  $\leq 300 \mu\text{s}$ ; duty cycle  $\leq 2\%$ .  
c. This is applied for IPAK,  $L_S$  of DPAK is measured between lead and center of die contact.

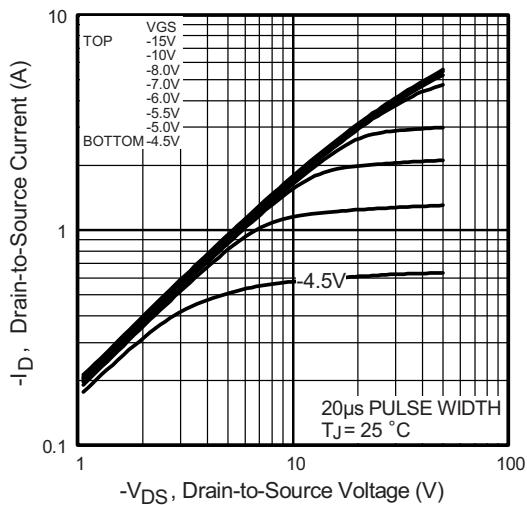
**TYPICAL CHARACTERISTICS** (25 °C, unless otherwise noted)

Fig. 1 - Typical Output Characteristics

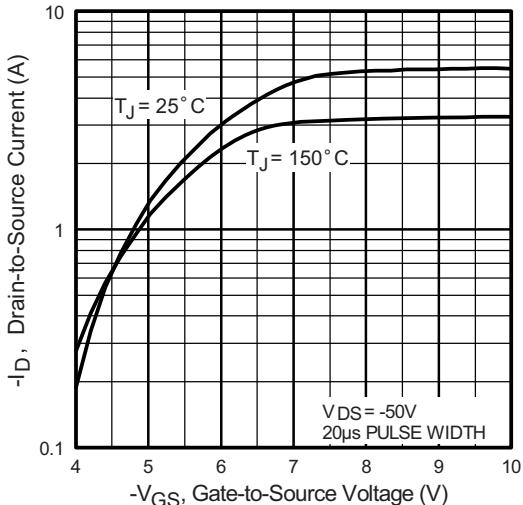


Fig. 3 - Typical Transfer Characteristics

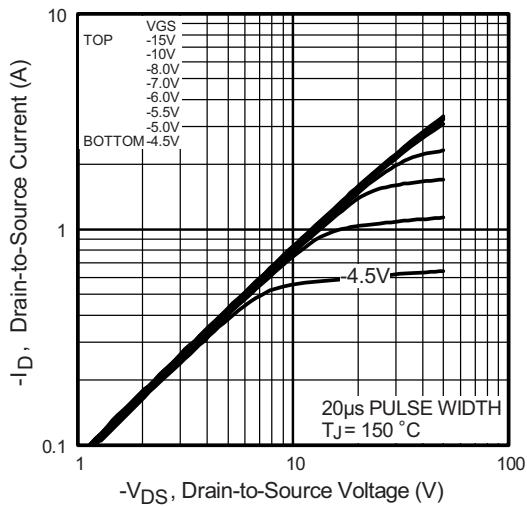


Fig. 2 - Typical Output Characteristics

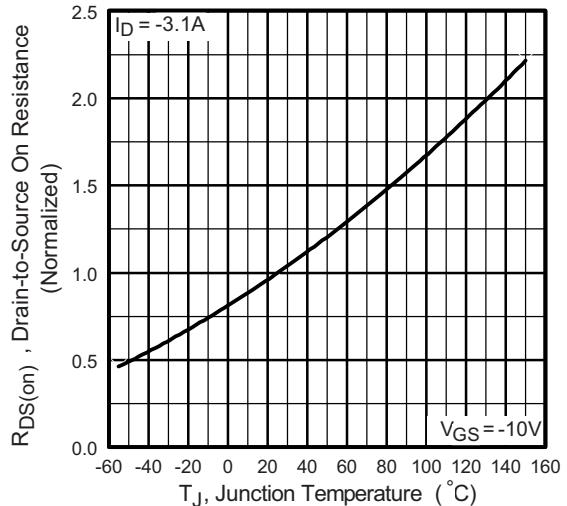
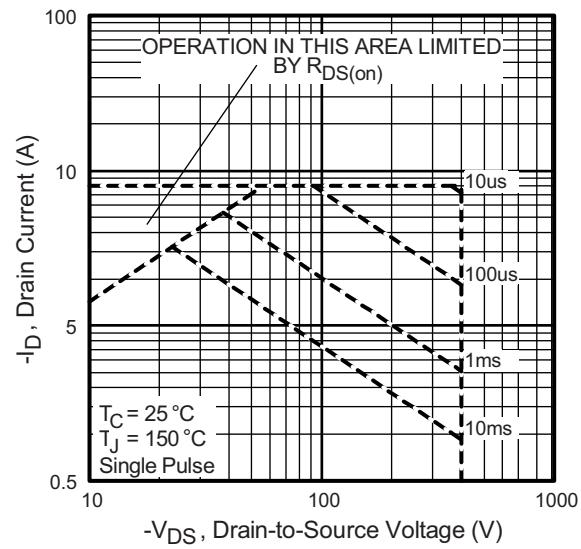
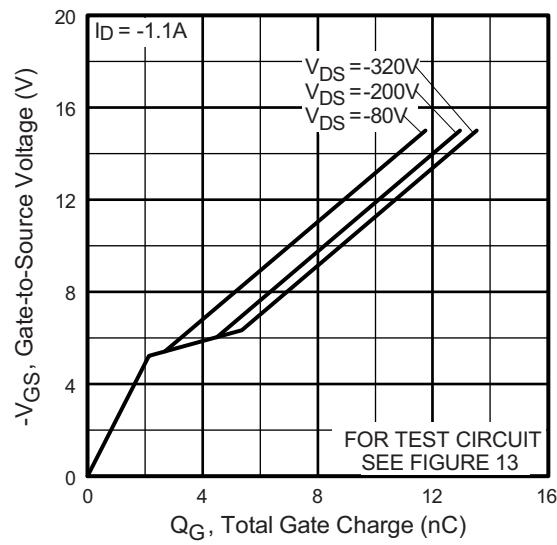
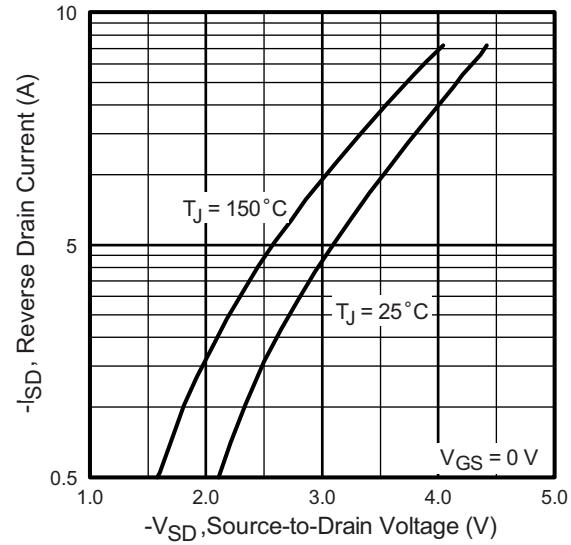
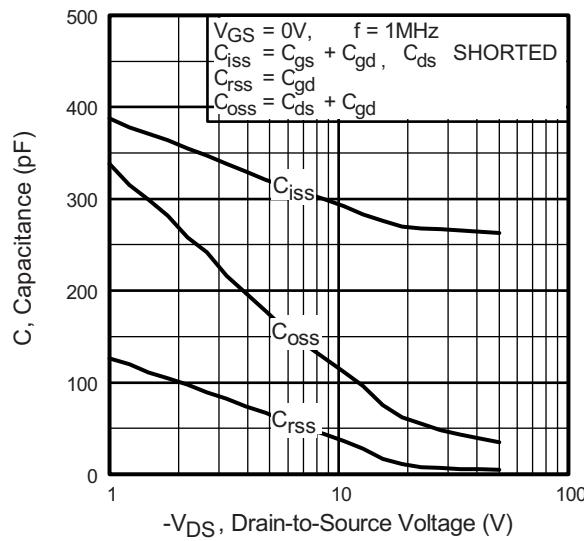


Fig. 4 - Normalized On-Resistance vs. Temperature



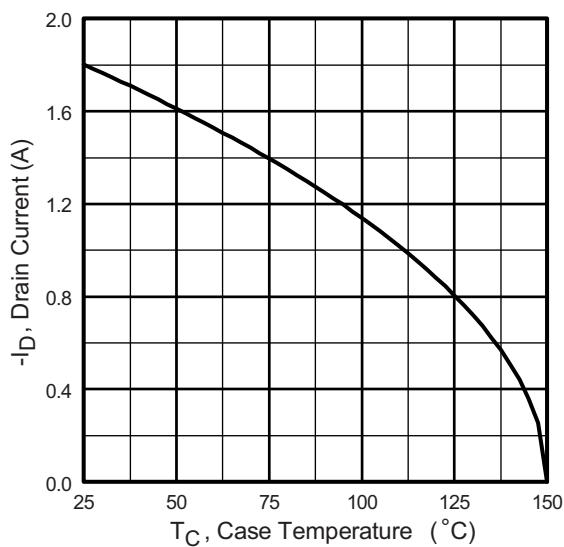


Fig. 9 - Maximum Drain Current vs. Case Temperature

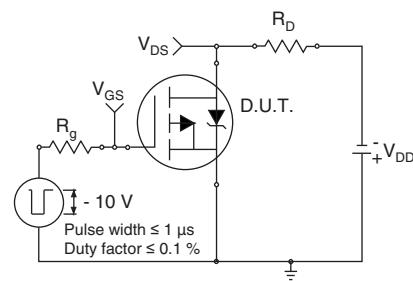


Fig. 10a - Switching Time Test Circuit

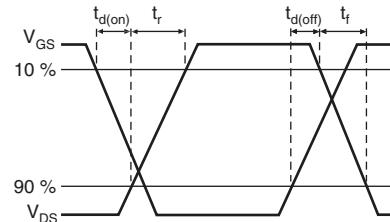


Fig. 10b - Switching Time Waveforms

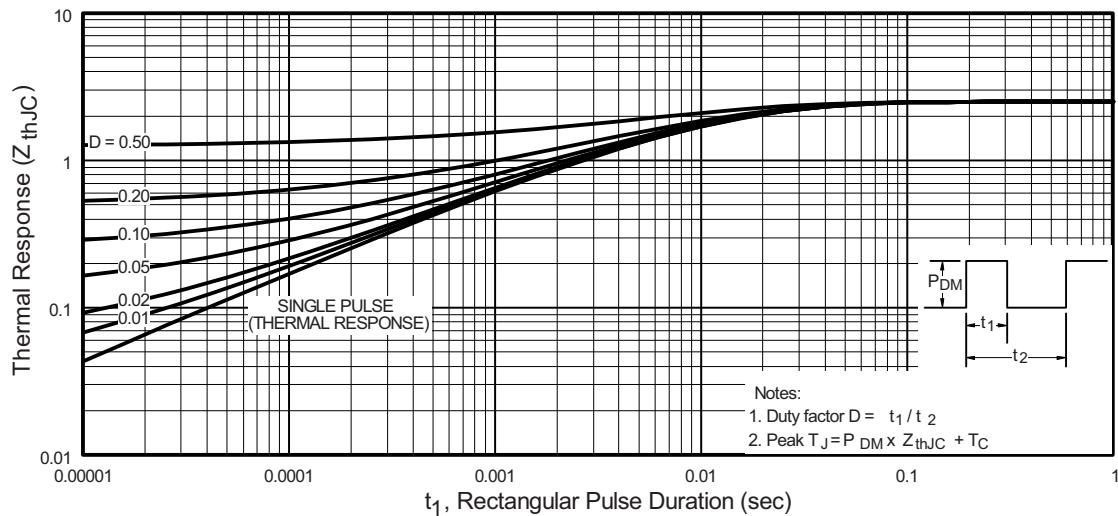


Fig. 11 - Maximum Effective Transient Thermal Impedance, Junction-to-Case

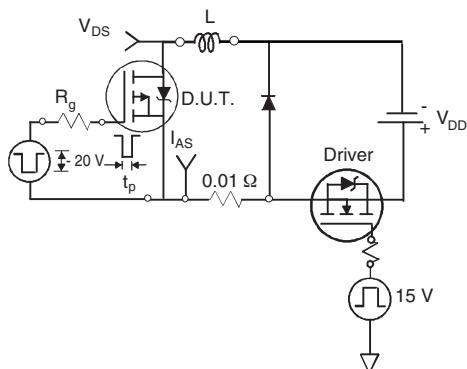


Fig. 12a - Unclamped Inductive Test Circuit

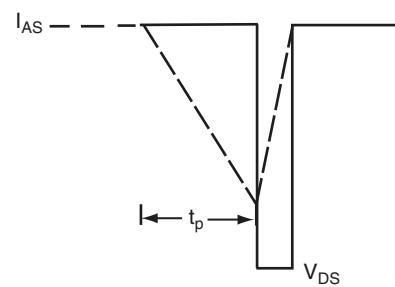


Fig. 12b - Unclamped Inductive Waveforms

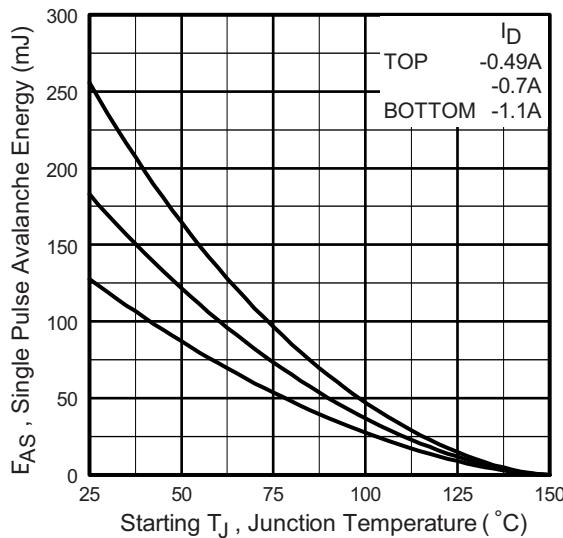


Fig. 12c - Maximum Avalanche Energy vs. Drain Current

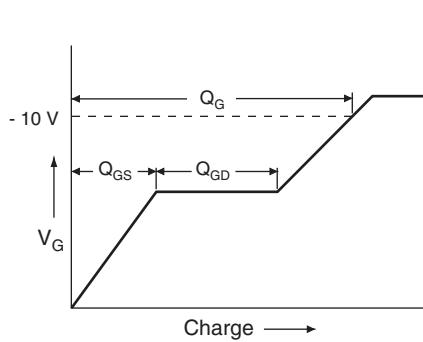


Fig. 13a - Basic Gate Charge Waveform

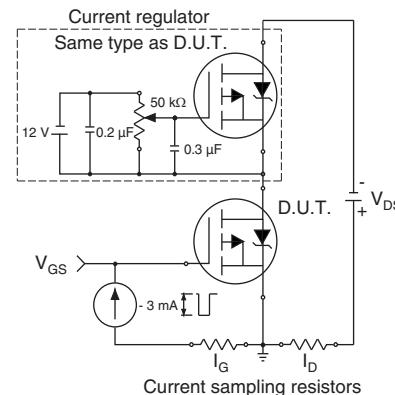
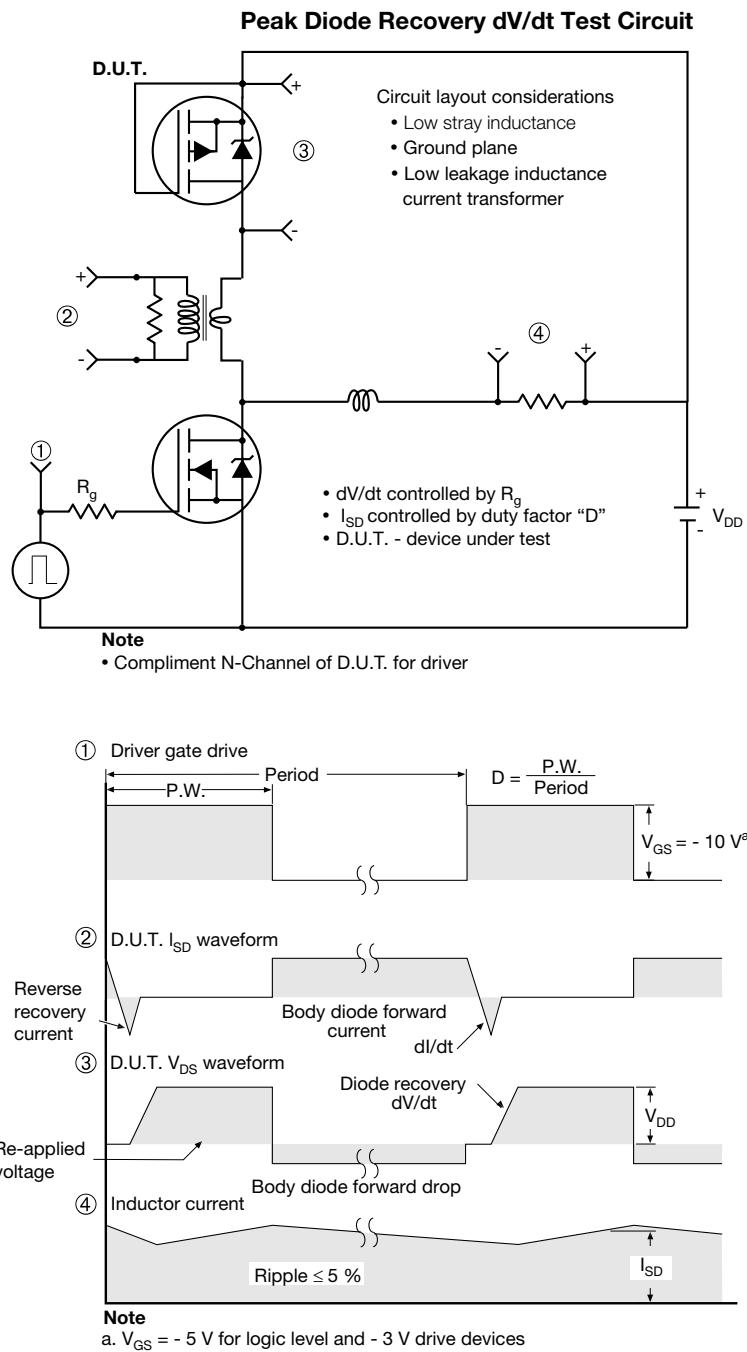
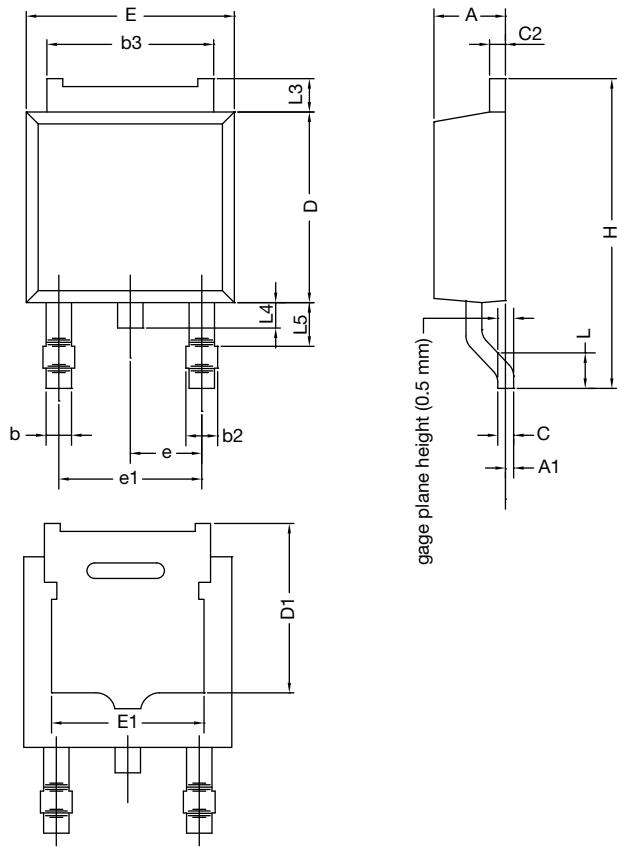


Fig. 13b - Gate Charge Test Circuit

**Fig. 14 - For P-Channel**

## TO-252AA Case Outline

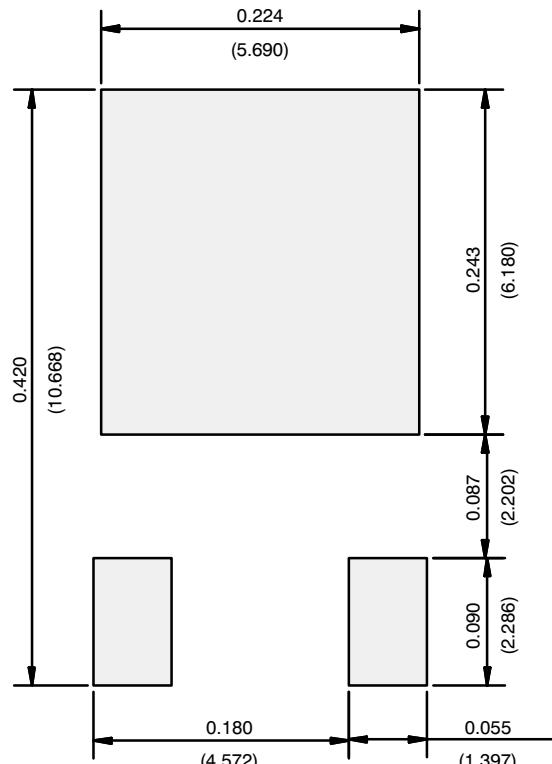


DIM.	MILLIMETERS		INCHES	
	MIN.	MAX.	MIN.	MAX.
A	2.18	2.38	0.086	0.094
A1	-	0.127	-	0.005
b	0.64	0.88	0.025	0.035
b2	0.76	1.14	0.030	0.045
b3	4.95	5.46	0.195	0.215
C	0.46	0.61	0.018	0.024
C2	0.46	0.89	0.018	0.035
D	5.97	6.22	0.235	0.245
D1	4.10	-	0.161	-
E	6.35	6.73	0.250	0.265
E1	4.32	-	0.170	-
H	9.40	10.41	0.370	0.410
e	2.28 BSC		0.090 BSC	
e1	4.56 BSC		0.180 BSC	
L	1.40	1.78	0.055	0.070
L3	0.89	1.27	0.035	0.050
L4	-	1.02	-	0.040
L5	1.01	1.52	0.040	0.060

ECN: T16-0236-Rev. P, 16-May-16  
DWG: 5347

### Notes

- Dimension L3 is for reference only.

**RECOMMENDED MINIMUM PADS FOR DPAK (TO-252)**

Recommended Minimum Pads  
Dimensions in Inches/(mm)

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